

	Class	Subclass
ISSUE CLASSIFICATION		

PATENT NUMBER

U.S. ~~UTILITY~~ Patent Application

SCANNED 201 Q.A. 65

PATENT DATE

APPLICATION NO. 09/678652	CONT/PRIOR	CLASS 436	SUBCLASS	ART UNIT 1655	EXAMINER
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APPLICANTS

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Method of inspecting a DNA chip and an apparatus thereof

TITLE

PTO-2040
12/99

ISSUING CLASSIFICATION												
ORIGINAL					CROSS REFERENCE(S)							
CLASS			SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
INTERNATIONAL CLASSIFICATION												

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	Sheets Drwg.	Figs. Drwg.	Print Fig.	Total Claims	Print Claim for O.G.
<input type="checkbox"/> The term of this patent subsequent to _____ (date) has been disclaimed.	_____ (Assistant Examiner) (Date)			NOTICE OF ALLOWANCE MAILED	
<input type="checkbox"/> The term of this patent shall not extend beyond the expiration date of U.S Patent. No. _____ _____ _____	_____ (Primary Examiner) (Date)			ISSUE FEE	
				Amount Due	Date Paid
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